

Notice of References Cited

Application/Control No.

10/606,624

Applicant(s)/Patent Under
Reexamination
OBERST, SHAWN

Examiner

David Garcia Cervetti

Art Unit

2436

Page 1 of 4

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2436

Page 2 of 4

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David Garcia Cervetti

Art Unit

2436

Page 3 of 4

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Art Unit

2436

Page 4 of 4

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	D	US-			
	E	US-			
	F	US-			
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